Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/674,035	LANG, JAS C.	
	Examiner	Art Unit	
	Sean E. Aeder, Ph.D.	1642	

ISSUE CLASSIFICATION

ORIGINAL						CROSS REFERENCE(S)						
CLASS				SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
435				6	536	23.1	24.31					
INTERNATIONAL CLASSIFICATION												
C	1	2	Q	1/68								
C	0	7	H	21/02								
C	0	7	H	21/04								
				/								
				/								

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Total Claims Allowed: 5

O.G. Print Claim(s)	O.G. Print Fig.
first	none

☒ **Claims renumbered in the same order as presented by applicant** ☐ CPA ☐ T.D. ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91		121		151		181
	2		32		62		92		122		152		182
	3		33		63		93		123		153		183
	4		34		64		94		124		154		184
	5		35		65		95		125		155		185
	6		36		66		96		126		156		186
	7		37		67		97		127		157		187
	8		38		68		98		128		158		188
	9		39		69		99		129		159		189
	10		40		70		100		130		160		190
	11		41		71		101		131		161		191
	12		42		72		102		132		162		192
	13		43		73		103		133		163		193
	14		44		74		104		134		164		194
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	16		46		76		106		136		166		196
	17		47		77		107		137		167		197
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	19		49		79		109		139		169		199
	20		50		80		110		140		170		200
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5	28		58		88		118		148		178		208
	29		59		89		119		149		179		209
	30		60		90		120		150		180		210